

Search Notes



Application/Control No.

10/757,782

Examiner

José V. Chen

Applicant(s)/Patent under
Reexamination

WUNSH ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
108	25 24 27 12 14 13 40 161	9/14/15	JLC
206	769 770 326		
ADACON 5/19/16 JLC			
ADACON 9/12/15 JLC			
ADACON 2/20/17 JLC			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Long Back Gr. For Post-Act	9/20/15	JLC
ADACON	9/19/15	JLC
✓ ADACON	2/20/17	JLC